

<b>Notice of References Cited</b>	Application/Control No. 10/783,501		Applicant(s)/Patent Under Reexamination IBRIC, ISMAIL	
	Examiner TAN X. DINH		Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,448,534 A	09-1995	Okada, Setsuo	369/7
*	B	US-6,163,508 A	12-2000	Kim et al.	369/7
*	C	US-5,633,837	05-1997	Gantt, Zaidy L.	369/7
*	D	US-5,671,195	09-1997	Lee, Howard Hong-Dough	369/7
*	E	US-6,324,126 B1	11-2001	Nagano, Susumu	369/7
*	F	US-6,407,750 B1	06-2002	Gioscia et al.	715/716
*	G	US-6,674,692 B1	01-2004	Holland, Darren	369/7
*	H	US-5,463,599 A	10-1995	Yifrach et al.	369/7
*	I	US-5,345,430 A	09-1994	Moe, Gordon	369/7
*	J	US-5,263,199 A	11-1993	Barnes et al.	455/344
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.